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## Comparative Study of the p-CdS/n-CdTe Photovoltaic Devices with Depleted Intrinsic Layer

A. Al Qassem, L. Gagara L., V. Fedorov, I. Lungu, and T. Potlog *Physics Department and Engineering Moldova State University Chisinau, Republic of Moldova* 

In fabricating CdS/CdTe photovoltaic devices by close space sublimation method, thermal annealed in CdCI<sub>2</sub> ambient at  $400^{\circ}$ C at the interface is deposited an *i*-CdO layer by magnetron sputtering. Comparative analysis of electrical, photovoltaic parameters and photo-response spectral distribution is studied. The insertion of *i*-CdO at the interface of device increases both short circuit current ( $I_{sc}$ ) and open circuit voltage ( $V_{oc}$ ). In addition, the experimental results revealed that the insertion of *i*-nanolayer broaden the depletion region of the device and diminish the interface state density, thus improving efficiency of the device.